INTEGRATED CIRCUITS

DATA SHEET

TDA8763A10-bit high-speed low-power ADC

Product specification Supersedes data of 1997 Feb 07 File under Integrated Circuits, IC02 1999 Jan 06





10-bit high-speed low-power ADC

TDA8763A

FEATURES

- 10-bit resolution
- · Sampling rate up to 50 MHz
- · DC sampling allowed
- · One clock cycle conversion only
- High signal-to-noise ratio over a large analog input frequency range (9.4 effective bits at 4.43 MHz full-scale input at f_{clk} = 40 MHz)
- · No missing codes guaranteed
- In-Range (IR) CMOS output
- · Levels TTL and CMOS compatible digital inputs
- 3 to 5 V CMOS digital outputs
- Low-level AC clock input signal allowed
- External reference voltage regulator
- Power dissipation only 175 mW (typical)
- Low analog input capacitance, no buffer amplifier required
- No sample-and-hold circuit required.

APPLICATIONS

High-speed analog-to-digital conversion for:

- Video data digitizing
- Radar pulse analysis
- · Transient signal analysis
- · High energy physics research
- ΣΔ modulators
- · Medical imaging.

GENERAL DESCRIPTION

The TDA8763A is a 10-bit high-speed low-power analog-to-digital converter (ADC) for professional video and other applications. It converts the analog input signal into 10-bit binary-coded digital words at a maximum sampling rate of 50 MHz. All digital inputs and outputs are TTL and CMOS compatible, although a low-level sine wave clock input signal is allowed.

The device requires an external source to drive its reference ladder. If the application requires that the reference is driven via internal sources the recommendation is to use the TDA8763.

ORDERING INFORMATION

TYPE NUMBER		PACKAGE		SAMPLING
TIPE NOWBER	NAME	DESCRIPTION	VERSION	FREQUENCY (MHz)
TDA8763AM/3	SSOP28		SOT341-1	30
TDA8763AM/4	SSOP28	plastic shrink small outline package; 28 leads; body width 5.3 mm	SOT341-1	40
TDA8763AM/5	SSOP28	body widin 5.5 mm	SOT341-1	50

10-bit high-speed low-power ADC

TDA8763A

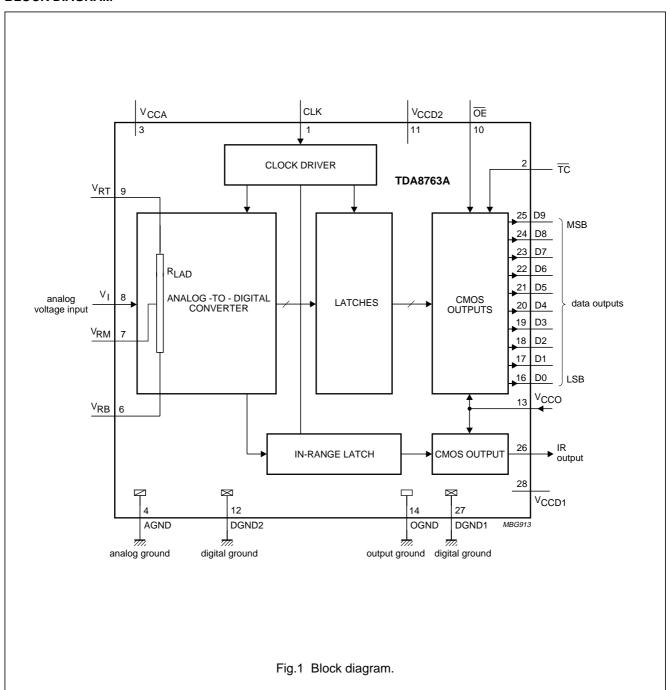
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{CCA}	analog supply voltage		4.75	5.0	5.25	V
V_{CCD}	digital supply voltage		4.75	5.0	5.25	V
V_{CCO}	output stages supply voltage		3.0	3.3	5.25	V
I _{CCA}	analog supply current		_	18	24	mA
I _{CCD}	digital supply current		_	16	21	mA
I _{CCO}	output stages supply current	f _{clk} = 40 MHz; ramp input	_	1	2	mA
INL	integral non-linearity	f _{clk} = 40 MHz; ramp input	_	±0.8	±2.0	LSB
DNL	differential non-linearity	f _{clk} = 40 MHz; ramp input	_	±0.5	±0.9	LSB
f _{clk(max)}	maximum clock frequency					
	TDA8763AM/3		30	_	_	MHz
	TDA8763AM/4		40	_	_	MHz
	TDA8763AM/5		50	_	_	MHz
P _{tot}	total power dissipation	f _{clk} = 40 MHz; ramp input	_	175	247	mW

10-bit high-speed low-power ADC

TDA8763A

BLOCK DIAGRAM

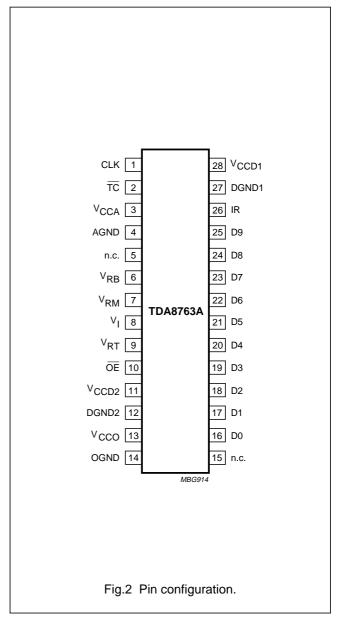


10-bit high-speed low-power ADC

TDA8763A

PINNING

SYMBOL	PIN	DESCRIPTION
CLK	1	clock input
TC	2	twos complement input (active LOW)
V _{CCA}	3	analog supply voltage (+5 V)
AGND	4	analog ground
n.c.	5	not connected
V _{RB}	6	reference voltage BOTTOM input
V_{RM}	7	reference voltage MIDDLE input
VI	8	analog input voltage
V _{RT}	9	reference voltage TOP input
ŌĒ	10	output enable input (CMOS level input, active LOW)
V_{CCD2}	11	digital supply voltage 2 (+5 V)
DGND2	12	digital ground 2
V _{CCO}	13	supply voltage for output stages (3 to 5 V)
OGND	14	output ground
n.c.	15	not connected
D0	16	data output; bit 0 (LSB)
D1	17	data output; bit 1
D2	18	data output; bit 2
D3	19	data output; bit 3
D4	20	data output; bit 4
D5	21	data output; bit 5
D6	22	data output; bit 6
D7	23	data output; bit 7
D8	24	data output; bit 8
D9	25	data output; bit 9 (MSB)
IR	26	in range data output
DGND1	27	digital ground 1
V _{CCD1}	28	digital supply voltage 1 (+5 V)



10-bit high-speed low-power ADC

TDA8763A

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CCA}	analog supply voltage	note 1	-0.3	+7.0	V
V_{CCD}	digital supply voltage	note 1	-0.3	+7.0	V
V _{CCO}	output stages supply voltage	note 1	-0.3	+7.0	V
ΔV_{CC}	supply voltage difference				
	V _{CCA} – V _{CCD}		-1.0	+1.0	V
	V _{CCA} – V _{CCO}		-1.0	+4.0	V
	V _{CCD} – V _{CCO}		-1.0	+4.0	V
VI	input voltage	referenced to AGND	-0.3	+7.0	V
V _{i(sw)(p-p)}	AC input voltage for switching (peak-to-peak value)	referenced to DGND	_	V _{CCD}	V
Io	output current		_	10	mA
T _{stg}	storage temperature		-55	+150	°C
T _{amb}	operating ambient temperature		-40	+85	°C
T _j	junction temperature		_	150	°C

Note

1. The supply voltages V_{CCA} , V_{CCD} and V_{CCO} may have any value between -0.3 V and +7.0 V provided that the supply voltage differences ΔV_{CC} are respected.

HANDLING

Inputs and outputs are protected against electrostatic discharges in normal handling. However, to be totally safe, it is desirable to take normal precautions appropriate to handling integrated circuits.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	110	K/W

10-bit high-speed low-power ADC

TDA8763A

CHARACTERISTICS

 $V_{CCA} = V_3 \text{ to } V_4 = 4.75 \text{ to } 5.25 \text{ V}; V_{CCD} = V_{11} \text{ to } V_{12} \text{ and } V_{28} \text{ to } V_{27} = 4.75 \text{ to } 5.25 \text{ V}; V_{CCO} = V_{13} \text{ to } V_{14} = 3.0 \text{ to } 5.25 \text{ V}; \\ AGND \text{ and DGND shorted together; } T_{amb} = 0 \text{ to } +70 \text{ }^{\circ}\text{C}; \text{ typical values measured at } V_{CCA} = V_{CCD} = 5 \text{ V} \text{ and } V_{CCO} = 3.3 \text{ V}; V_{i(p-p)} = 2.0 \text{ V}; C_L = 15 \text{ pF and } T_{amb} = 25 \text{ }^{\circ}\text{C}; \text{ unless otherwise specified.}$

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply				•		
V _{CCA}	analog supply voltage		4.75	5.0	5.25	V
V _{CCD1}	digital supply voltage 1		4.75	5.0	5.25	V
V _{CCD2}	digital supply voltage 2		4.75	5.0	5.25	V
V _{CCO}	output stages supply voltage		3.0	3.3	5.25	V
ΔV_{CC}	supply voltage difference					
	V _{CCA} – V _{CCD}		-0.20	_	+0.20	V
	V _{CCA} – V _{CCO}		-0.20	_	+2.25	V
	V _{CCD} – V _{CCO}		-0.20	_	+2.25	V
I _{CCA}	analog supply current		_	18	24	mA
I _{CCD}	digital supply current		_	16	21	mA
I _{CCO}	output stages supply current	f _{clk} = 40 MHz; ramp input	_	1	2	mA
Inputs				•		•
CLOCK INPL	UT CLK (REFERENCED TO DGND);	note 1				
V _{IL}	LOW-level input voltage		0		0.8	V
V _{IH}	HIGH-level input voltage		2.0	_	V _{CCD}	V
I _{IL}	LOW-level input current	V _{clk} = 0.8 V	-1	0	+1	μΑ
I _{IH}	HIGH-level input current	V _{clk} = 2.0 V	_	2	10	μΑ
Z _i	input impedance	f _{clk} = 40 MHz	_	2	_	kΩ
C _i	input capacitance		_	2	_	pF
INPUTS OE	AND TC (REFERENCED TO DGND)	; see Table 2	'	'	<u>'</u>	•
V _{IL}	LOW-level input voltage		0	_	0.8	V
V _{IH}	HIGH-level input voltage		2.0	_	V _{CCD}	V
I _{IL}	LOW-level input current	V _{IL} = 0.8 V	-1	_	_	μΑ
I _{IH}	HIGH-level input current	V _{IH} = 2.0 V	_	_	1	μΑ
V _I (ANALOG	INPUT VOLTAGE REFERENCED TO A	GND)	'	'	-1	'
I _{IL}	LOW-level input current	V _I = V _{RB} = 1.3 V	_	0	_	μΑ
I _{IH}	HIGH-level input current	V _I = V _{RT} = 3.67 V	_	35	_	μΑ
Z _i	input impedance	f _i = 4.43 MHz	_	8	_	kΩ
C _i	input capacitance		_	5	_	pF
	voltages for the resistor ladde	r see Table 1			1	1
V _{RB}	reference voltage BOTTOM		1.2	1.3	2.45	V
V _{RT}	reference voltage TOP		3.2	3.67	V _{CCA} - 0.8	V
V _{diff}	differential reference voltage V _{RT} – V _{RB}		2.0	2.37	3.0	V
I _{ref}	reference current	$V_{RT} - V_{RB} = 2.37 \text{ V}$	_	9.7	_	mA

10-bit high-speed low-power ADC

TDA8763A

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{lad}	resistor ladder		_	245	1-	Ω
TC _{Rlad}	temperature coefficient of the		_	1860	_	ppm
	resistor ladder		_	456	_	mΩ/K
V _{offset(B)}	offset voltage BOTTOM	$V_{RT} - V_{RB} = 2.37 \text{ V}$; note 2	_	175	_	mV
V _{offset(T)}	offset voltage TOP	$V_{RT} - V_{RB} = 2.37 \text{ V}$; note 2	_	175	_	mV
$V_{i(p-p)}$	analog input voltage (peak-to-peak value)	note 3	1.70	2.02	2.55	V
Outputs						
DIGITAL OU	TPUTS D9 TO D0 AND IR (REFEREN	ICED TO OGND)				
V _{OL}	LOW-level output voltage	I _{OL} = 1 mA	0	_	0.5	V
V _{OH}	HIGH-level output voltage	I _{OH} = −1 mA	V _{CCO} - 0.5	_	V _{CCO}	V
I _{OZ}	output current in 3-state mode	0.5 V < V _o < V _{CCO}	-20	_	+20	μΑ
Switching	characteristics				•	•
CLOCK INPL	JT CLK; see Fig.4; note 1					
f _{clk(max)}	maximum clock frequency					
	TDA8763AM/3		30	_	_	MHz
	TDA8763AM/4		40	_	_	MHz
	TDA8763AM/5		50	_	_	MHz
t _{CPH}	clock pulse width HIGH	full effective bandwidth	8.5	_	-	ns
t _{CPL}	clock pulse width LOW	full effective bandwidth	5.5	_	_	ns
Analog sig	gnal processing			•	•	•
LINEARITY						
INL	integral non-linearity	f _{clk} = 40 MHz; ramp input	_	±0.8	±2.0	LSB
DNL	differential non-linearity	f _{clk} = 40 MHz; ramp input	_	±0.5	±0.9	LSB
E _{offset}	offset error	middle code; $V_{RB} = 1.3 \text{ V}$; $V_{RT} = 3.67 \text{ V}$	_	±1	_	LSB
E _G	gain error (from device to device) using external reference voltage	V _{RB} = 1.3 V; V _{RT} = 3.67 V; note 4	-	±0.1	-	%

10-bit high-speed low-power ADC

TDA8763A

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
BANDWIDTH	H (f _{clk} = 40 MHz)		1	<u>'</u>	-	- '
В	analog bandwidth	full-scale sine wave; note 5	_	15	_	MHz
		75% full-scale sine wave; note 5	_	20	_	MHz
		small signal at mid-scale; $V_I = \pm 10$ LSB at code 512; note 5	_	350	_	MHz
t _{stLH}	analog input settling time LOW-to-HIGH	full-scale square wave; see Fig.6; note 6	_	1.5	3.0	ns
t _{stHL}	analog input settling time HIGH-to-LOW	full-scale square wave; see Fig.6; note 6	_	1.5	3.0	ns
HARMONICS	$S(f_{clk} = 40 \text{ MHz}); \text{ see Figs 7 and 8}$	3				
H _{fund(FS)}	fundamental harmonics (full-scale)	f _i = 4.43 MHz	_	_	0	dB
H _{all(FS)}	harmonics (full-scale); all components	f _i = 4.43 MHz				
	second harmonics		_	-75	-65	dB
	third harmonics		_	-72	-65	dB
THD	total harmonic distortion	f _i = 4.43 MHz	_	-64	_	dB
SIGNAL-TO-	NOISE RATIO; see Figs 7 and 8; no	ote 7				
SNR _{FS}	signal-to-noise ratio (full-scale)	without harmonics; f _{clk} = 40 MHz; f _i = 4.43 MHz	55	58	_	dB
EFFECTIVE	BITS; see Figs 7 and 8; note 7					
EB	effective bits	TDA8763AM/3; f _{clk} = 30 MHz				
		f _i = 4.43 MHz	_	9.4	_	bits
		f _i = 7.5 MHz	_	9.1	_	bits
		TDA8763AM/4; f _{clk} = 40 MHz				
		f _i = 4.43 MHz	_	9.4	_	bits
		f _i = 7.5 MHz	_	9.0	_	bits
		f _i = 10 MHz	_	8.9	_	bits
		f _i = 15 MHz	_	8.1	_	bits
		TDA8763AM/5; f _{clk} = 50 MHz				
		f _i = 4.43 MHz	_	9.3	_	bits
		f _i = 7.5 MHz	-	8.9	-	bits
		f _i = 10 MHz	_	8.8	_	bits
		f _i = 15 MHz	_	8.0	_	bits

10-bit high-speed low-power ADC

TDA8763A

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
TWO-TONE;	note 8	•	•		•	•
TTIR	two-tone intermodulation rejection	f _{clk} = 40 MHz	_	-69	_	dB
BIT ERROR	RATE			·		·
BER	bit error rate	$ f_{\text{Clk}} = 50 \text{ MHz}; $ $ f_{\text{I}} = 4.43 \text{ MHz}; $ $ V_{\text{I}} = \pm 16 \text{ LSB at code 512} $	-	10 ⁻¹³	_	times/ sample
DIFFERENT	IAL GAIN; note 9		•	·	•	·
G _{diff}	differential gain	f _{clk} = 40 MHz; PAL modulated ramp	_	0.8	_	%
DIFFERENT	IAL PHASE; note 9					
Ψdiff	differential phase	f _{clk} = 40 MHz; PAL modulated ramp	_	0.4	_	deg
Timing (fc	_{lk} = 40 MHz ; C _L = 15 pF) ; see Fig	g.4; note 10		•	•	•
t _{ds}	sampling delay time		_	3	_	ns
t _h	output hold time		4	_	_	ns
t _d	output delay time	V _{CCO} = 4.75 V	_	10	13	ns
		V _{CCO} = 3.15 V	_	12	15	ns
C_{L}	digital output load capacitance		_	_	15	pF
3-state ou	tput delay times; see Fig.5					
t _{dZH}	enable HIGH		_	5.5	8.5	ns
t _{dZL}	enable LOW		_	12	15	ns
t _{dHZ}	disable HIGH		_	19	24	ns
t _{dLZ}	disable LOW		_	12	15	ns

Notes

- 1. In addition to a good layout of the digital and analog ground, it is recommended that the rise and fall times of the clock must not be less than 0.5 ns.
- 2. Analog input voltages producing code 0 up to and including code 1023:
 - a) $V_{offset(B)}$ (voltage offset BOTTOM) is the difference between the analog input which produces data equal to 00 and the reference voltage BOTTOM (V_{RB}) at T_{amb} = 25 °C.
 - b) $V_{offset(T)}$ (voltage offset TOP) is the difference between reference voltage TOP (V_{RT}) and the analog input which produces data outputs equal to code 1023 at $T_{amb} = 25$ °C.

10-bit high-speed low-power ADC

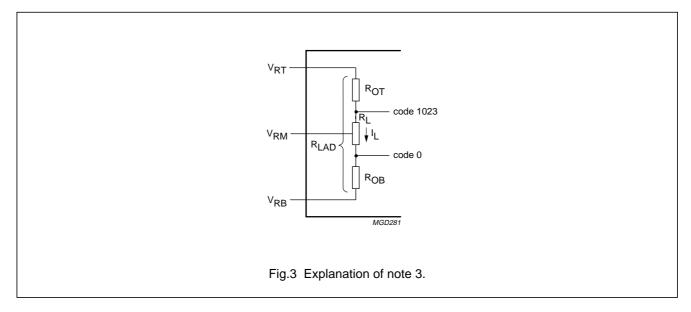
TDA8763A

In order to ensure the optimum linearity performance of such converter architecture the lower and upper extremities
of the converter reference resistor ladder (corresponding to output codes 0 and 1023 respectively) are connected to
pins V_{RB} and V_{RT} via offset resistors R_{OB} and R_{OT} as shown in Fig.3.

a) The current flowing into the resistor ladder is $I_L = \frac{V_{RT} - V_{RB}}{R_{OB} + R_L + R_{OT}}$ and the full-scale input range at the converter,

to cover code 0 to code 1023, is
$$V_I = R_L \times I_L = \frac{R_L}{R_{OB} + R_L + R_{OT}} \times (V_{RT} + -V_{RB}) = \dot{0.852} \times (V_{RT} - V_{RB})$$

- b) Since R_L , R_{OB} and R_{OT} have similar behaviour with respect to process and temperature variation, the ratio $\frac{RL}{ROB + RL + ROT}$ will be kept reasonably constant from device to device. Consequently variation of the output codes at a given input voltage depends mainly on the difference $V_{RT} V_{RB}$ and its variation with temperature and supply voltage. When several ADCs are connected in parallel and fed with the same reference source, the matching between each of them is then optimized.
- 4. $E_G = \frac{(V_{1023} V_0) V_{i(p-p)}}{V_{i(p-p)}} \times 100$
- 5. The analog bandwidth is defined as the maximum input sine wave frequency which can be applied to the device. No glitches greater than 2 LSBs, neither any significant attenuation are observed in the reconstructed signal.
- 6. The analog input settling time is the minimum time required for the input signal to be stabilized after a sharp full-scale input (square wave signal) in order to sample the signal and obtain correct output data.
- 7. Effective bits are obtained via a Fast Fourier Transform (FFT) treatment taking 8K acquisition points per equivalent fundamental period. The calculation takes into account all harmonics and noise up to half of the clock frequency (NYQUIST frequency). Conversion to signal-to-noise ratio: SINAD = ENOB × 6.02 + 1.76 dB.
- 8. Intermodulation measured relative to either tone with analog input frequencies of 4.43 MHz and 4.53 MHz. The two input signals have the same amplitude and the total amplitude of both signals provides full-scale to the converter.
- 9. Measurement carried out using video analyser VM700A, where the video analog signal is reconstructed through a digital-to-analog converter.
- 10. Output data acquisition: the output data is available after the maximum delay time of t_{d(max)}. For 50 MHz version it is recommended to have the lowest possible output load.



1999 Jan 06

10-bit high-speed low-power ADC

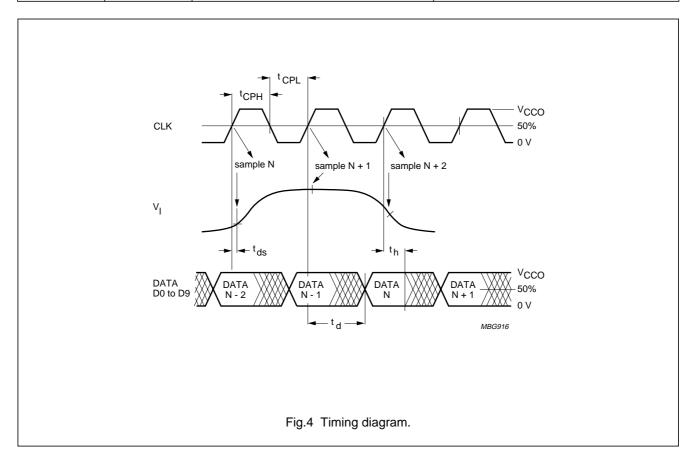
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Table 1 Output coding and input voltage (typical values; referenced to AGND, $V_{RB} = 1.3 \text{ V}$, $V_{RT} = 3.67 \text{ V}$)

STEP	V	IR			ВІ	NAR	Y OL	JTPU	T BI	TS			•	TWO	'S C	ОМР	LEM	ENT	OUT	PUT	BITS	;
SIEF	V _{i(p-p)}	IK	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
U/F	<1.475	0	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0
0	1.475	1	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0
1		1	0	0	0	0	0	0	0	0	0	1	1	0	0	0	0	0	0	0	0	1
			•				•										•				•	
		•	•				•										•				•	
1022		1	1	1	1	1	1	1	1	1	1	0	0	1	1	1	1	1	1	1	1	0
1023	3.495	1	1	1	1	1	1	1	1	1	1	1	0	1	1	1	1	1	1	1	1	1
O/F	>3.495	0	1	1	1	1	1	1	1	1	1	1	0	1	1	1	1	1	1	1	1	1

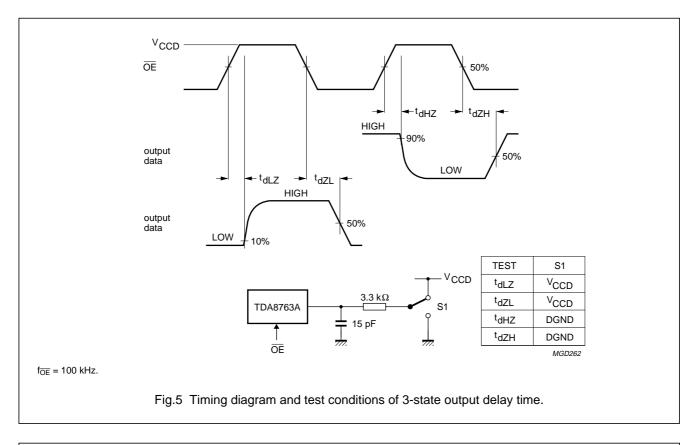
Table 2 Mode selection

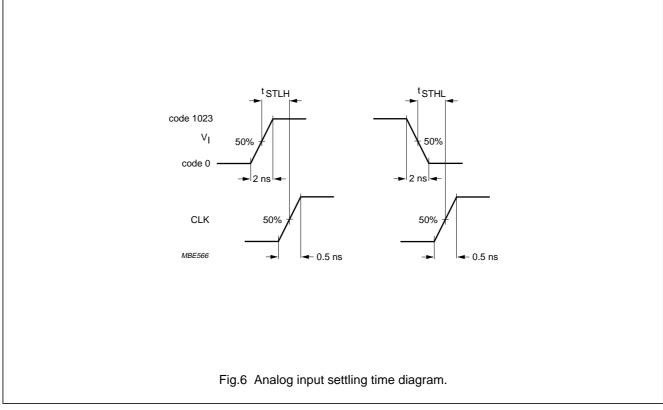
TC	ŌĒ	D9 to D0	IR
Х	1	high impedance	high impedance
0	0	active; twos complement	active
1	0	active; binary	active



10-bit high-speed low-power ADC

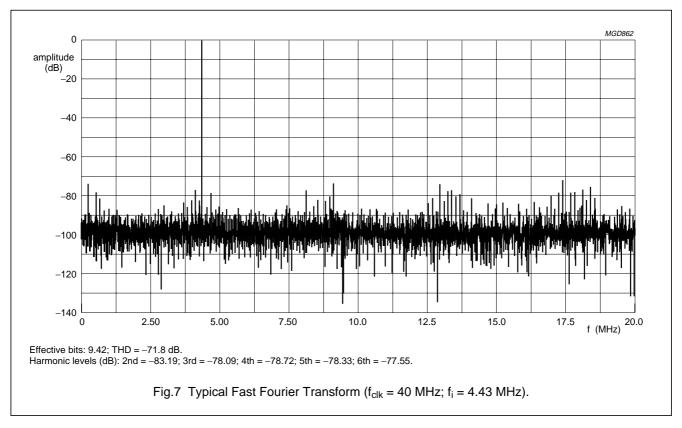
TDA8763A

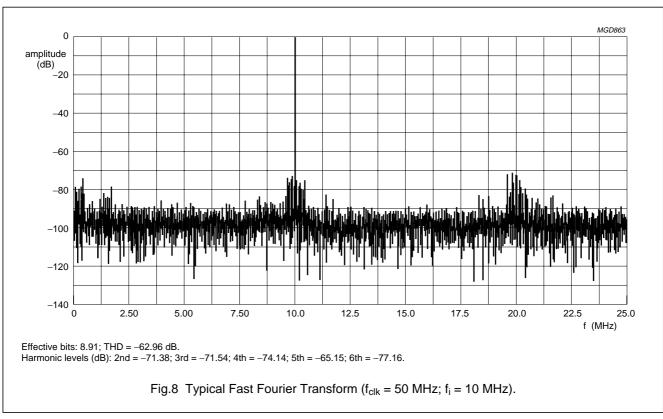




10-bit high-speed low-power ADC

TDA8763A

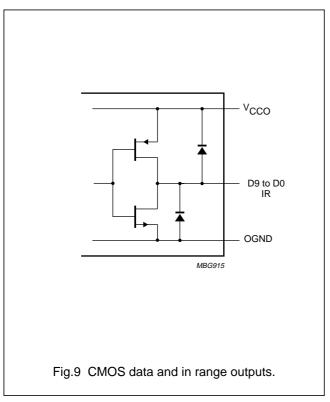


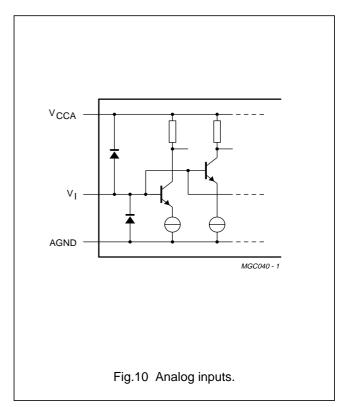


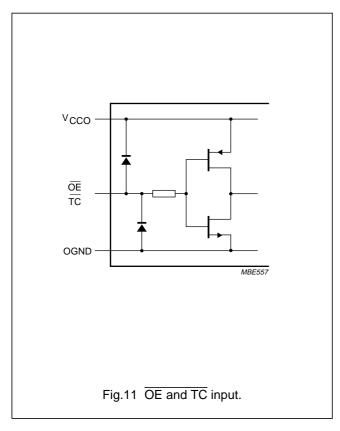
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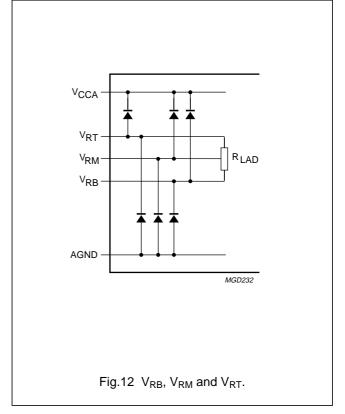
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INTERNAL PIN CONFIGURATIONS



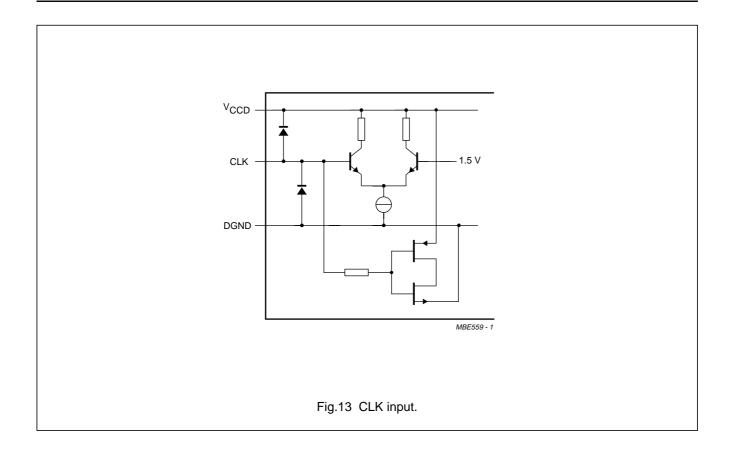






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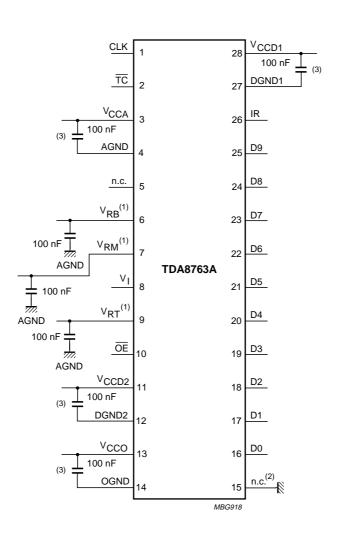
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10-bit high-speed low-power ADC

TDA8763A

APPLICATION INFORMATION



The analog and digital supplies should be separated and well decoupled.

An application note is available and describes the design and the realization of a demonstration board that uses the version TDA8768AM with an application environment.

- (1) V_{RB} , V_{RM} and V_{RT} are decoupled to AGND.
- (2) Pin 15 may be connected to DGND in order to prevent noise influence.
- (3) Decoupling capacitor for supplies; must be placed close to the device.

Fig.14 Application diagram.

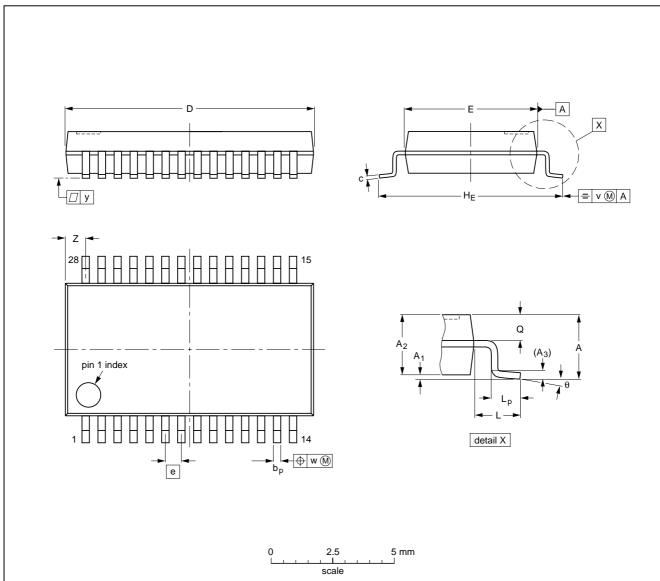
10-bit high-speed low-power ADC

TDA8763A

PACKAGE OUTLINE

SSOP28: plastic shrink small outline package; 28 leads; body width 5.3 mm

SOT341-1



DIMENSIONS (mm are the original dimensions)

U	NIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
r	nm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	10.4 10.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.1 0.7	8° 0°

Note

1. Plastic or metal protrusions of 0.20 mm maximum per side are not included.

OUTLINE VERSION		REFERENCES			EUROPEAN	ISSUE DATE
	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
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SOLDERING

Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "Data Handbook IC26; Integrated Circuit Packages" (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering is not always suitable for surface mount ICs, or for printed-circuit boards with high population densities. In these situations reflow soldering is often used.

Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, infrared/convection heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 230 °C.

Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

 For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to $300~^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 $^{\circ}$ C.

1999 Jan 06

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Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE	SOLDERING METHOD			
PACKAGE	WAVE	REFLOW ⁽¹⁾		
BGA, SQFP	not suitable	suitable		
HLQFP, HSQFP, HSOP, HTSSOP, SMS	not suitable ⁽²⁾	suitable		
PLCC ⁽³⁾ , SO, SOJ	suitable	suitable		
LQFP, QFP, TQFP	not recommended ⁽³⁾⁽⁴⁾	suitable		
SSOP, TSSOP, VSO	not recommended ⁽⁵⁾	suitable		

Notes

- 1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the "Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods".
- 2. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).
- 3. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- 4. Wave soldering is only suitable for LQFP, TQFP and QFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- 5. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

DEFINITIONS

Data sheet status				
Objective specification	This data sheet contains target or goal specifications for product development.			
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			
Limiting values				
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or				

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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